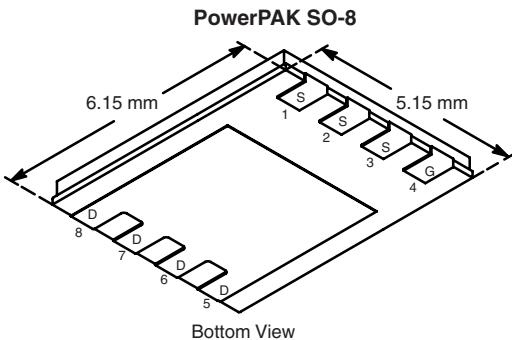


P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A)	Q_g (Typ.)
- 20	0.0019 at $V_{GS} = - 10$ V	- 60 ^d	128 nC
	0.0030 at $V_{GS} = - 4.5$ V	- 60 ^d	



Ordering Information: Si7141DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

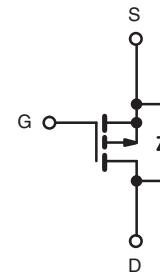


FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Adaptor Switch
- Battery Switch
- Load Switch



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	- 20	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_J = 150$ °C)	I_D	- 60 ^d	A
		- 60 ^d	
		- 42.7 ^b	
		- 34 ^b	
Pulsed Drain Current	I_{DM}	- 100	
Continuous Source-Drain Diode Current	I_S	- 60 ^d	
		- 5.6 ^{a, b}	
Avalanche Current	I_{AS}	- 40	
Single-Pulse Avalanche Energy	E_{AS}	80	mJ
Maximum Power Dissipation	P_D	104	W
		66.6	
		6.25 ^{a, b}	
		4.0 ^{a, b}	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) ^{e, f}		260	

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, c}	R_{thJA}	15	20	°C/W
Maximum Junction-to-Case	R_{thJC}	0.9	1.2	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. $t = 10$ s.
- c. Maximum under Steady State conditions is 54 °C/W.
- d. Package limited.
- e. See Solder Profile (www.vishay.com/doc?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- f. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

Si7141DP

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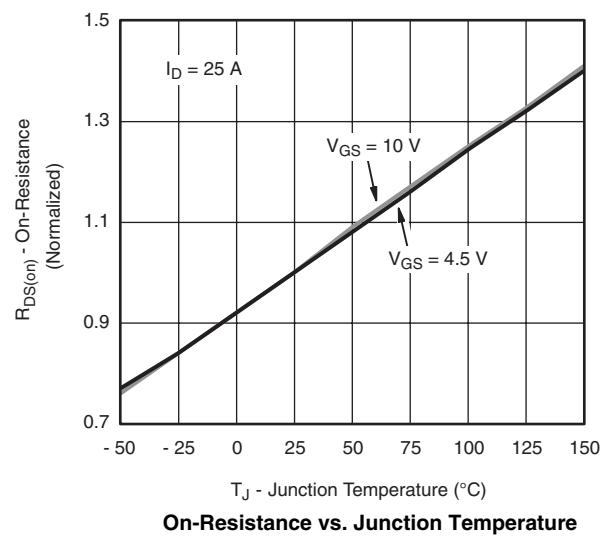
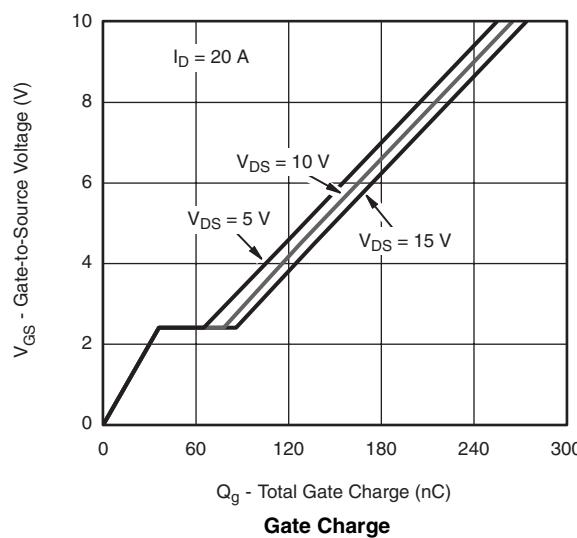
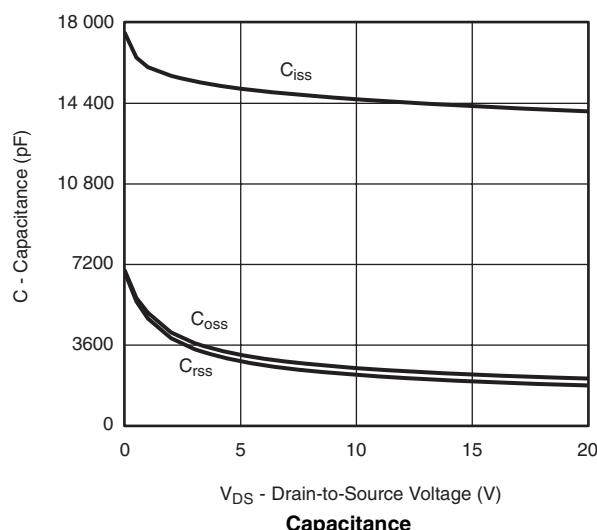
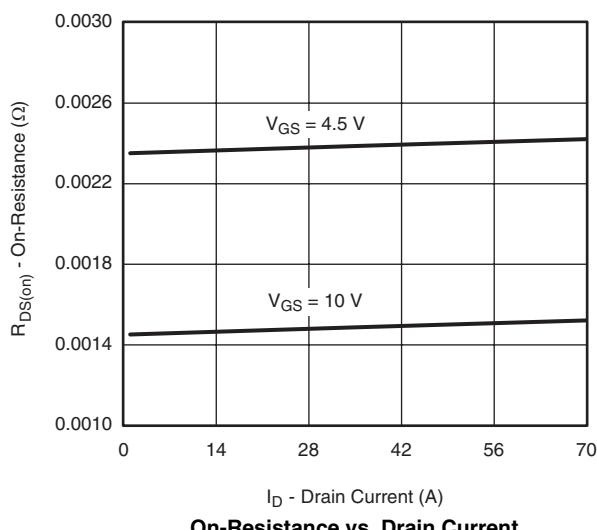
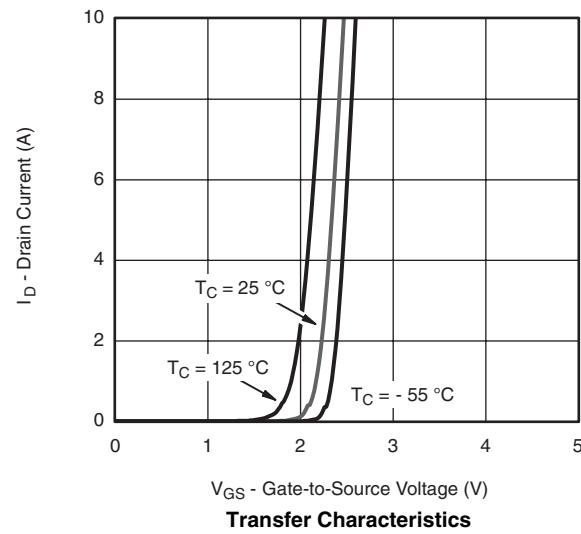
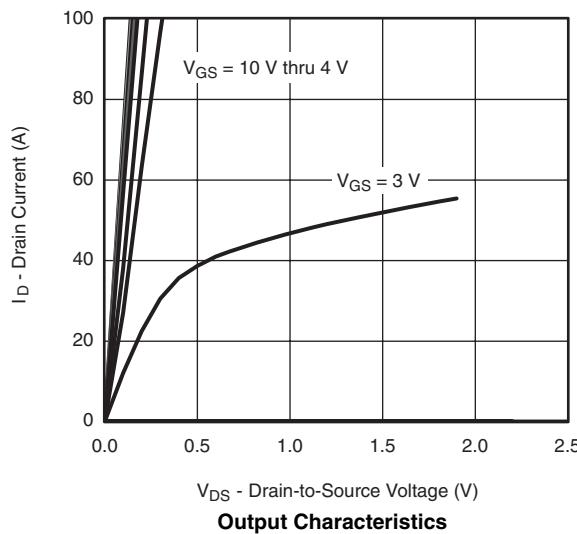
**SPECIFICATIONS** $T_J = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = -250 \mu\text{A}$		-16		mV/ $^\circ\text{C}$
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$			5.7		
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$	-1.0		-2.3	V
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μA
		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$			-5	
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{DS} \geq -10 \text{ V}, V_{GS} = -10 \text{ V}$	-40			A
Drain-Source On-State Resistance ^a	$R_{DS(\text{on})}$	$V_{GS} = -10 \text{ V}, I_D = -25 \text{ A}$		0.0015	0.0019	Ω
		$V_{GS} = -4.5 \text{ V}, I_D = -20 \text{ A}$		0.0024	0.0030	
Forward Transconductance ^a	g_{fs}	$V_{DS} = -10 \text{ V}, I_D = -25 \text{ A}$		103		S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		14 300		pF
Output Capacitance	C_{oss}			2300		
Reverse Transfer Capacitance	C_{rss}			2600		
Total Gate Charge	Q_g	$V_{DS} = -10 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -20 \text{ A}$		265	400	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -20 \text{ A}$		128	194	
Gate-Drain Charge	Q_{gd}			36		
Gate Resistance	R_g		$f = 1 \text{ MHz}$	0.4	1.7	3.4
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -10 \text{ V}, R_L = 1 \Omega$ $I_D \equiv -10 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		25	50	ns
Rise Time	t_r			16	30	
Turn-Off DelayTime	$t_{d(\text{off})}$			130	220	
Fall Time	t_f			38	70	
Turn-On Delay Time	$t_{d(\text{on})}$			130	220	
Rise Time	t_r			120	200	
Turn-Off DelayTime	$t_{d(\text{off})}$			100	180	
Fall Time	t_f			55	100	
Drain-Source Body Diode Characteristics						
Continous Source-Drain Diode Current	I_S	$T_C = 25^\circ\text{C}$			-60	A
Pulse Diode Forward Current	I_{SM}				-100	
Body Diode Voltage	V_{SD}	$I_S = -5 \text{ A}, V_{GS} = 0 \text{ V}$		-0.71	-1.1	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = -10 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$		42	80	ns
Body Diode Reverse Recovery Charge	Q_{rr}			36	72	nC
Reverse Recovery Fall Time	t_a			18		ns
Reverse Recovery Rise Time	t_b			24		

Notes:

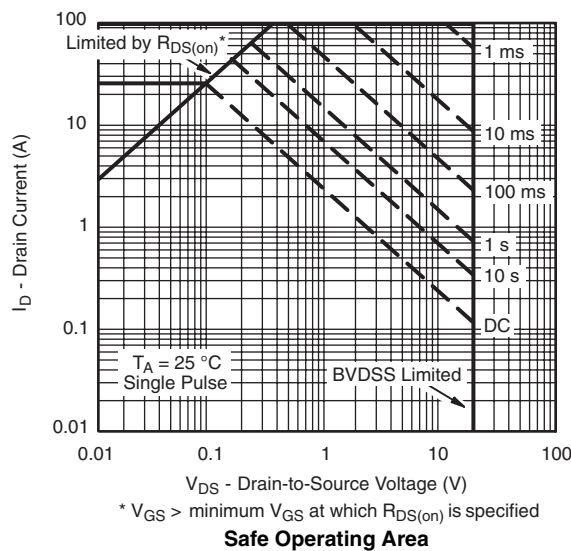
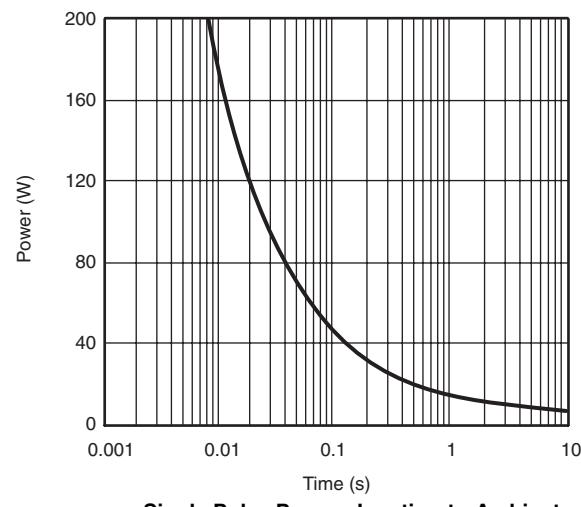
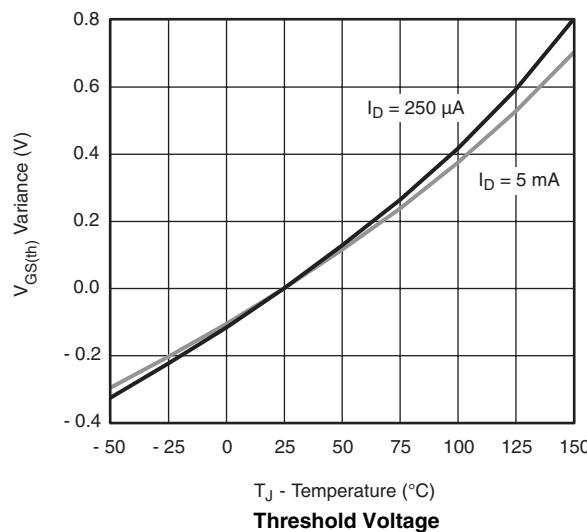
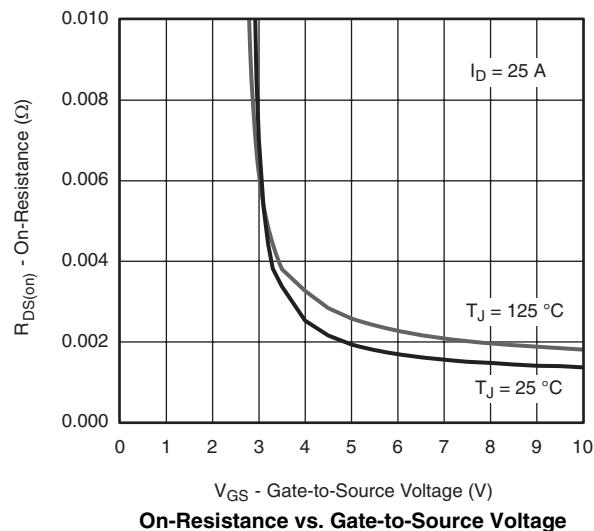
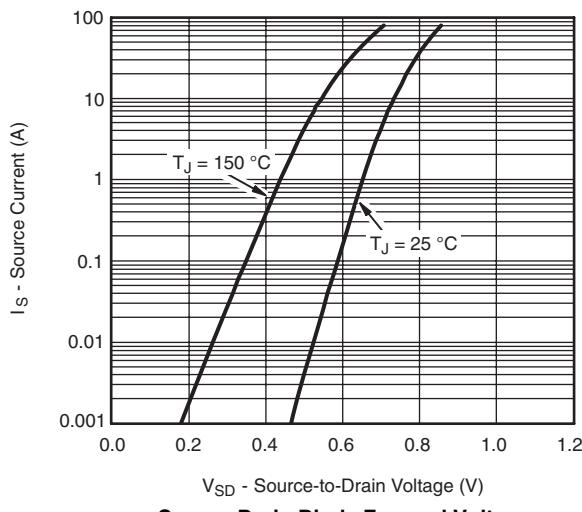
- a. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.
b. Guaranteed by design, not subject to production testing.

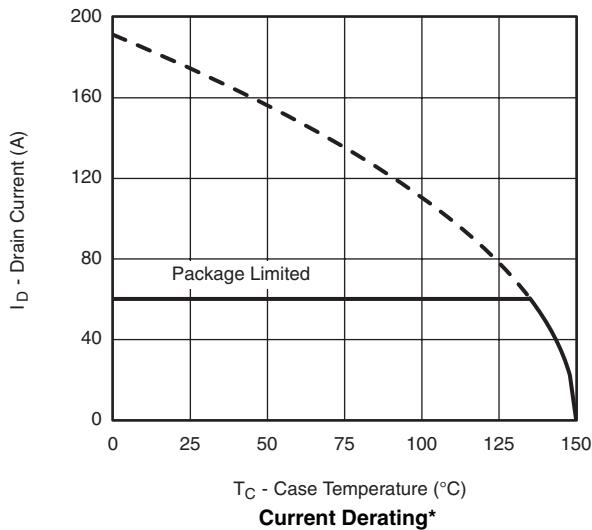
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

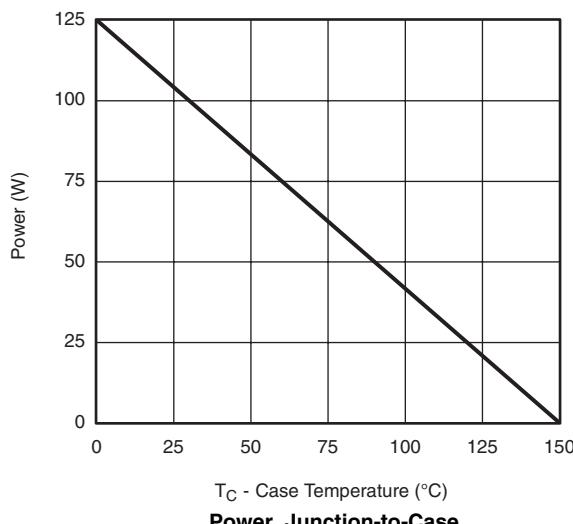
Si7141DP

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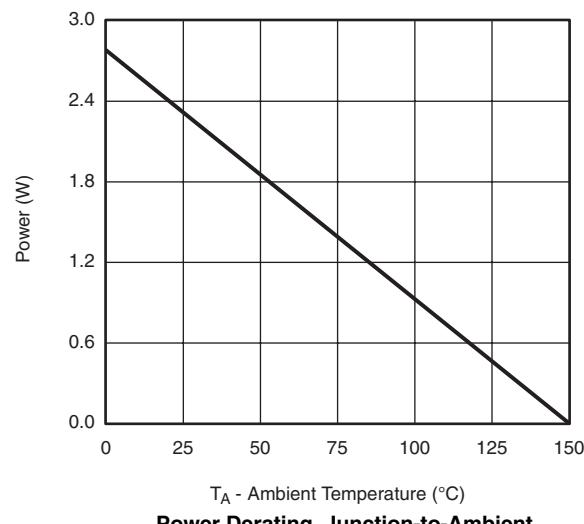
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted T_C - Case Temperature (°C)

Current Derating*

 T_C - Case Temperature (°C)

Power, Junction-to-Case

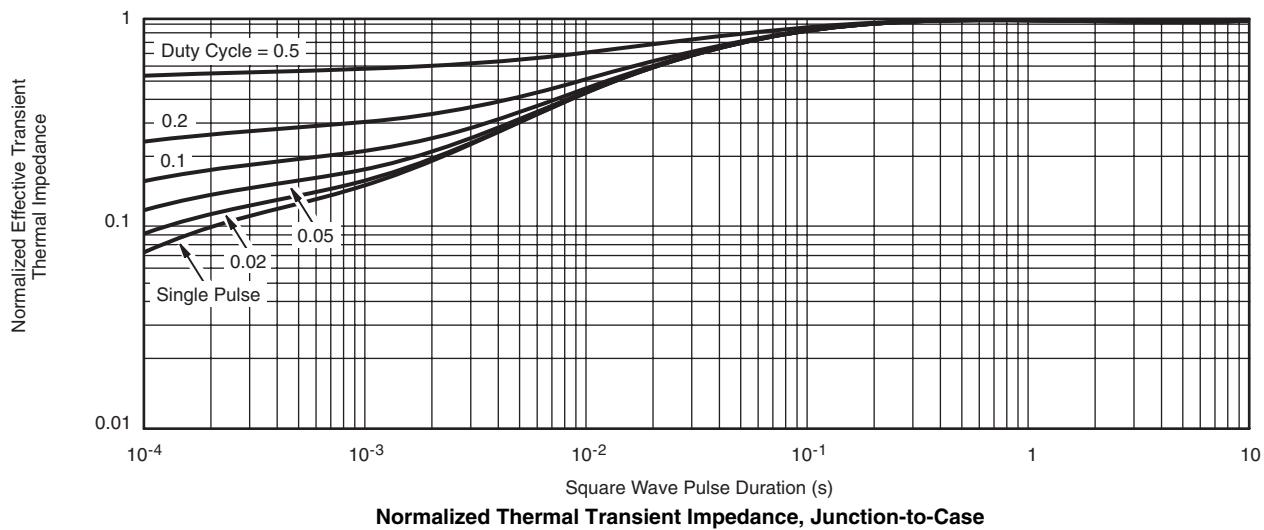
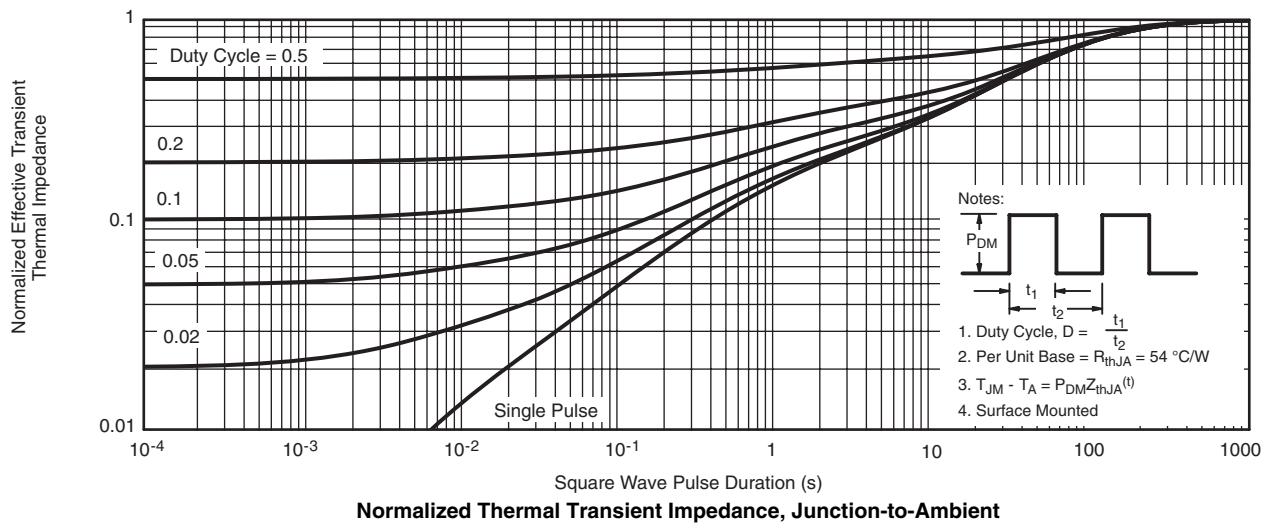
 T_A - Ambient Temperature (°C)

Power Derating, Junction-to-Ambient

* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

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